## WHAT IS CLAIMED IS:

1. A photosensitive polymer having a trifluorovinyl derivative monomer as a repeating unit and having a weight average molecular weight of about 3,000 to about 100,000, the trifluorovinyl derivative represented by the following formula:

5

10

15

wherein X is a C<sub>1</sub>-C<sub>5</sub> alkyl group with or without fluorine substituent, and G is at least one selected from the group consisting of:

- wherein R is a primary, secondary or tertiary  $C_1$ - $C_{10}$  alkyl, tetrahydropyranyl, tetrahydrofuranyl or 1-ethoxyethyl group, and n is an integer from 1 to 5.
  - 2. The photosensitive polymer according to claim 1, wherein the photosensitive polymer is a polymerization product of the trifluorovinyl derivative monomer and at least one monomer selected from the group consisting of a fluorine-substituted or unsubstituted (meth)acrylic acid monomer, (meth)acrylate monomer, styrene monomer, norbornene monomer, tetrafluoroethylene monomer and maleic anhydride monomer.

## 3. A resist composition comprising:

a photosensitive polymer having a trifluorovinyl derivative monomer as a repeating unit and having a weight average molecular weight of about 3,000 to about 100,000, the trifluorovinyl derivative represented by the following formula:

wherein X is a C<sub>1</sub>-C<sub>5</sub> alkyl group with or without fluorine substituent, and G is at least one selected from the group consisting of:

$$F_{3}C \bigvee_{HO} \bigcap_{CF_{3}} F_{3}C \bigvee_{CF_{3}} \bigcap_{CF_{3}} \bigcap_{CF_{3}}$$

wherein R is a primary, secondary or tertiary  $C_1$ - $C_{10}$  alkyl, tetrahydropyranyl, tetrahydrofuranyl or 1-ethoxyethyl group, and n is an integer from 1-5; and

a photoacid generator in an amount of about 1 to about 15% by weight based on the total weight of the photosensitive polymer.

4. The resist composition according to claim 3, wherein the photosensitive polymer is a polymerization product of the trifluorovinyl derivative monomer and at least one monomer selected from the group consisting of a fluorine-substituted or unsubstituted (meth)acrylic acid monomer, (meth)acrylate monomer, styrene monomer, norbornene monomer, tetrafluoroethylene monomer and maleic anhydride monomer.

10

15

5

- 5. The resist composition according to claim 3, further comprising an organic base in an amount of about 0.01 to about 2.0% by weight based on the total weight of the photosensitive polymer.
  - 6. A patterning method comprising:
- (a) coating a resist composition on a substrate, wherein the resist composition comprises:

a photosensitive polymer having a trifluorovinyl derivative monomer as a repeating unit and having a weight average molecular weight of about 3,000 to about 100,000, the trifluorovinyl derivative represented by the following formula:

5

10

15

20

wherein X is a C<sub>1</sub>-C<sub>5</sub> alkyl group with or without fluorine substituent, and G is at least one selected from the group consisting of:

$$F_{3}C \xrightarrow{\text{C}} CF_{3} \xrightarrow{\text{C}} CF_{3}$$

$$F_{3}C \xrightarrow{\text{C}} CF_{3} \xrightarrow{\text{C}} CF_{3}$$

wherein R is a primary, secondary or tertiary C<sub>1</sub>-C<sub>10</sub> alkyl, tetrahydropyranyl, tetrahydrofuranyl or 1-ethoxyethyl group, and n is an integer from 1-5; and

a photoacid generator in an amount of about 1 to about 15% by weight based on the total weight of the photosensitive polymer;

- (b) exposing the resist layer using an exposure light source having a wavelength of 157 nm or less; and
  - (c) developing the exposed resist layer to form a resist pattern.

7. The patterning method of claim 6, wherein the photosensitive polymer is a polymerization product of the trifluorovinyl derivative monomer and at least one monomer selected from the group consisting of a fluorine-substituted or unsubstituted (meth)acrylic acid monomer, (meth)acrylate monomer, styrene monomer, norbornene monomer, tetrafluoroethylene monomer and maleic anhydride monomer.

5

10

8. The patterning method of claim 6, wherein the resist composition further comprises an organic base in an amount of about 0.01 to about 2.0% by weight based on the total weight of the photosensitive polymer.